

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION 規格書

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CATEGORY (品名) DESCRIPTION (型号) VERSION (版本) Customer P/N SUPPLIER		ECTROLYTIC CAPACITORS 5x11)

SUPPL	IER	CUST	FOMER
PREPARED (拟定)	CHECKED (审核)	APPROVAL (批准)	SIGNATURE (签名)
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ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

		SPECIFICAT	ALTERNATION HISTORY RECORDS				
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`a t	ble 1 Product Dime Safety vent for $\geq \Phi 6.3$	nsions a	nd Ch	aracteristic	es.						Unit: m	ım		
	$L^{+\alpha}_{-1.0}$		5 min	$\downarrow \phi d \pm 0.03$	-		-0.5	β Φ * If it is	20:α=1.5; L D<20:β=0. flat rubber, urface.	5; ΦD≥20	: β=1.0	from th	ie flat r	ubber
N).	SAMXON Part No.	WV (Vdc)	Cap. (µF)	Cap. tolerance	Temp. range(°C)	tanδ Leak (120Hz, Curr 20°C) (μ A,2	ent	Max Ripple Current at 105°C 100KHz (mA rms)	Impedance at 20°C 100kHz (Ωmax)	Load lifetime (Hrs)	Dir D×L	nensiou (mm) F	n ¢d	Slee

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ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

Part Number System 2. 7 123 4 5 6 89 101112 1314 1516 17 D P EGS 1 0 5 М 1 H 1 1 тс S Α SERIES CAPACITANCE TOL VOLTAGE CASE SIZE SLEEVE SAMXON SLEEVE PRODUCT LINE MATERIAL TYPE Code Tolerance (%) Code Cap(MFD) Voltage (W.V.) Code Case Size Feature Code SAMXON Product Lin Case 5126 Diameter(#) Code 3 B 3.5 1 4 C 5 D 6.3 E 8 F 10 G 12.5 1 13 J ESM EKF ESS EKS 0D 2 For internal use only Radial bulk RR 104 0.1 ±5 J 2.5 0E (The product lines 4 0G we have H,A,B,C,D, Ammo Taping 0.22 224 G ±10 к 6.3 OJ E,M or 0,1,2,3,4,5,9). EKM EKG EOM 8 0K 0.33 2.0mm Pitch тτ 334 10 1A ± 15 L 12.5 1B JV4AK7 τυ ZS EGF ESF EG 2.5mm Pitch 0.47 474 13.5 14 16 1C Μ 20 1D ±20 тν 1 105 14.5 3.5mm Pitch Sleeve Ma 25 1E EGK EGE EGD EGC 16 16.5 18 30 11 5.0mm Pitch тс PET Р 18 18 20 22 25 30 34 35 42 42 51 2.2 225 Ν +3032 13 1V Lead Cut & Form 35 ERS 3.3 335 -40 w 40 1G СВ 42 1**M** CB-Type 475 4.7 -20 Α 50 1H CE-Type CE 57 1L 106 10 ERI ERI EBI -20 +10 63 1J С HE-Type HE 226 45 51 53.5 76 80 90 100 1S 22 71 ERA ERB ERC 1**T** 75 6 -20 +40 х KD-Type КD 33 336 80 1K 85 1R -20 +50 ENF ENF ERV ERV s FD-Type FD 47 476 19 90 100 2A 4.5 5 5.4 45 EH-Type EH -10 107 в 100 05 54 07 77 120 20 2B 125 PCB Termial 220 227 -10 +20 v 7. 10.2 11 5 150 27 160 2G sw 330 337 -10 +30 0 180 $2\mathbf{P}$ EUP 2D 200 Snap-in sx 470 477 -10 +50 12 т 215 22 220 2N 13.5 sz 2200 228 ESF -5 +10 230 23 20 Е Lug SG 250 2E 29.5 22000 229 -5 +15 275 2T F 3 05 300 21 1.5 33000 339 35 35.5 50 100 105 110 120 120 -5 +20 310 2R G 06 315 2F 47000 479 330 2U 0 +20 R Т5 350 2V 100000 10T Screw 0 +30 360 2X 0 Т6 375 2Q 150000 15T 0 +50 385 2Y I D5 400 2G 220000 22T +5 +15 420 2M z D6 450 2W 330000 33T +5 500 2H D 550 25 1000000 10M +10+50 Y 600 26 630 2J 1500000 15M +10 н 2200000 22M 3300000 33M 5

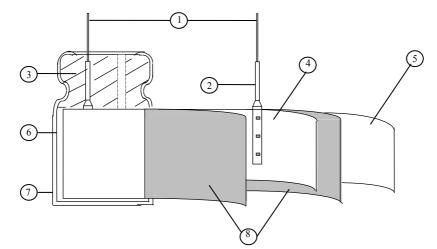
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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	РЕТ
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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Tabl	ITEM				PERFC	RMAN	CE			
	Rated voltage									
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100
4.1		SV (V.DC)	8	13	20	31	44	63	79	125
	Surge voltage (SV)			I		L	L		l	
4.2	Nominal capacitance (Tolerance)	Condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria>	requency oltage emperat	: N ure : 20)±2℃	han 0.5V				
4.3	Leakage current	<condition> Connecting t minutes, and <criteria> Refer to Table</criteria></condition>	he capao then, me		-		istor (1	$k \Omega \pm 10$	Ω) in s	eries for 2
4.4	tan δ	<condition> See 4.2, Norr <criteria> Refer to Table</criteria></condition>	n Capac	itance, fo	or measur	ing frequ	iency, vo	oltage and	l tempera	ature.
4.5	Terminal strength	0.5r	ength of capacitor rength of pacitor,	, applied Termina applied f nds, and d wire	force to lls. force to b then ber Tens	ent the te	erminal (0° to its	1~4 mm t original j Bending (kg 2.5 (from the position force N gf)	rubber) for
		<criteri< b=""> No notic</criteri<>		anges sh	all be for	and, no b	reakage	or loosen	ess at the	e terminal.

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		<condition></condition>		T				T		
		STEP	Testi		rature(°C)		, 1	Time	.1.1 .	
		1	_	20 ± 2			to reach		•	
		2	- (-)			to reach				
		3		20 ± 2			to reach		•	
		4		$105\pm$	2	Time	to reach	thermal e	equilibri	um
		5		20 ± 2	2	Time	to reach	thermal e	equilibri	um
		<criteria></criteria>								
		a. tan δ shal				4.4The l	eakage cu	irrent me	easured s	shall not
	Temperature	more than 8 t		1			4 4 7 7 1			
	characteristi	b. In step 5,			nin the lin	nt of Iter	n 4.4The	leakage	current	shall not
4.6	cs	more than the	-			111	1.4	1	641 6	11
		c. At-40 $^{\circ}$ C (- table.	-25 C), 11	mpedance	(Z) ratio s	shall not	exceed th	e value o	of the to	llowing
		Working Volt	age (V)	6.3	10	16	25	35	50	63
		Z-25°C/Z+2	20°C	4	3	2	2	2	2	2
		Z-40°C/Z+	20°C	8	6	4	3	3	3	3
		Working Volta	age (V)	100]					
		Z-25°C/Z+2	- · ·	2	-					
		Z-40°C/Z+2		3	-					
		For capacitan			F. Add 0.	5 per ano	ther 1000)µF for	Z-25/Z+	-20℃.
						-				
					Add 1.0) per ano	ther 1000	μ F for Z	Z-40°C/Z	Z+20°C.
		Capacitance, t	an δ , and	d impedar) per ano e measur			Z-40°C/2	Z+20°C.
		<condition></condition>		-	nce shall b	e measur	red at 120	Hz.		
		<condition> According to</condition>	IEC6038	34-4No.4.	nce shall b	e measur	ed at 120	Hz.	it a temp	erature of
		Condition According to $105^{\circ}C \pm 2$ with	IEC6038 ith DC bi	34-4No.4. as voltage	13 method plus the	e measur ls, The ca	ed at 120 pacitor is	Hz. s stored a t for Tab	nt a temp ble 1. (T	erature of
		Condition> According to 105°C ±2 wi DC and ripp	IEC6038 ith DC bi le peak	34-4No.4. as voltage voltage sł	13 method plus the mail not estimates of the second	e measur ls, The ca rated ripp sceed the	pacitor is le curren e rated w	Hz. s stored a t for Tab orking v	nt a temp ble 1. (T voltage)	erature of he sum of Then the
		Condition> According to 105°C ±2 wi DC and ripp product shoul	IEC6038 ith DC bi le peak v ld be teste	34-4No.4. as voltage voltage sh ed after 16	13 method e plus the mall not ex 6 hours red	e measur ls, The ca rated ripp sceed the	pacitor is le curren e rated w	Hz. s stored a t for Tab orking v	nt a temp ble 1. (T voltage)	erature of he sum of Then the
4.7	Load	Condition> According to 105°C ±2 wi DC and ripp product shoul result should	IEC6038 ith DC bi le peak v ld be teste	34-4No.4. as voltage voltage sh ed after 16	13 method e plus the mall not ex 6 hours red	e measur ls, The ca rated ripp sceed the	pacitor is le curren e rated w	Hz. s stored a t for Tab orking v	nt a temp ble 1. (T voltage)	erature of he sum of Then the
4.7	life	Condition> According to 105°C ± 2 wi DC and ripp product shoul result should <criteria></criteria>	EC6038 ith DC bi le peak d be teste meet the	34-4No.4. as voltage voltage sh ed after 16 following	13 method 13 method e plus the r nall not e: 6 hours red g table:	e measur ls, The ca rated ripp acceed the covering	ed at 120 apacitor is le curren e rated w time at at	Hz. s stored a t for Tab orking v	nt a temp ble 1. (T voltage)	erature of he sum of Then the
4.7		Condition> According to 105°C ±2 wi DC and ripp product shoul result should <criteria> The characte</criteria>	IEC6038 ith DC bi le peak ld be teste meet the ristic sha	34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	13 method e plus the f hall not e: 5 hours red g table: e followin	e measur ls, The ca rated ripp cceed the covering g require	ed at 120 upacitor is le curren e rated w time at at	Hz. s stored a t for Tab rorking v mospher	nt a temp ble 1. (T voltage)	erature of he sum of Then the
4.7	life	<condition>According to$105^{\circ}C \pm 2$ withDC and rippingproduct shouldresult should<criteria>The characterLeakage</criteria></condition>	IEC6038 ith DC bi le peak v ld be testa meet the ristic sha ge curren	34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t	13 method 13 method e plus the r fall not ex 6 hours red g table: <u>e followin</u> Value in	e measur ls, The ca rated ripp kceed the covering <u>g require</u> 4.3 shall	ed at 120 apacitor is le curren e rated w time at at <u>ements.</u> be satisfi	Hz. s stored a t for Tab orking v mospher ed	nt a temp ble 1. (T voltage)	erature of he sum of Then the
4.7	life	Condition> According to 105°C ± 2 wi DC and ripp product should result should <criteria> The character Leakaş Capac</criteria>	IEC6038 ith DC bi le peak ld be teste meet the ristic sha	34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t	13 method plus the p all not e: 5 hours red 5 table: e followin Value in Within	e measur ls, The ca rated ripp covering <u>g require</u> 4.3 shall 25% of	ed at 120 upacitor is le curren e rated w time at at ements. be satisfi initial va	Hz. s stored a t for Tab rorking v mospher ed ilue.	tt a temp ble 1. (T voltage) ic condi	erature of he sum of Then the tions. The
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4.7	life	Condition> According to 105°C ± 2 wi DC and ripp product should result should <criteria> The character Leakaş Capac</criteria>	IEC6038 ith DC bi le peak v ld be testa meet the ristic sha ge curren itance Ch	34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t	13 method plus the p all not e: 5 hours red 5 table: e followin Value in Within	e measur ls, The ca rated ripp covering g require 4.3 shall 25% of e than 20	ed at 120 upacitor is ile curren e rated w time at at <u>ements.</u> <u>be satisfi</u> initial va 0% of the	Hz. s stored a t for Tab rorking v mospher ed ilue. specifie	t a temp ole 1. (T voltage) ic condi	erature of he sum of Then the tions. The
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	life test Shelf life	<condition>According to$105^{\circ}C \pm 2$ withDC and rippingproduct shouldresult should<criteria>The characterLeakageCapacetan δAppea<td>IEC6038 ith DC bi le peak v ld be testa meet the ristic sha ge curren itance Ch rance are then burs. Foll be allow nected to Omin. Aft</td><td>34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t nange stored wi lowing thi ved to stal a series</td><td>13 method e plus the f nall not e: 6 hours red g table: e followin Within <u>d</u> Not more There sh th no volta is period t bilized at limiting re</td><td>e measur ls, The carated ripp cated ripp covering g require 4.3 shall 25% of a than 20 all be no all be no age applic he capac room ter esistor(11</td><td>ed at 120 upacitor is le currente rated w time at at ments. be satisfi initial va 0% of the leakage of ed at a ten itors shall uperature $c\pm 100 \Omega$</td><td>Hz. s stored a t for Tab rorking v mospher ed ilue. specifie of electro mperatur l be remo for 4~8) with E</td><td>tt a temp ble 1. (T voltage) ic condi ed value. lyte. re of 105 oved fro hours. D.C. rate</td><td>erature of he sum of Then the tions. The $\pm 2^{\circ}C$ for m the tes Next they ed voltage</td></criteria></condition>	IEC6038 ith DC bi le peak v ld be testa meet the ristic sha ge curren itance Ch rance are then burs. Foll be allow nected to Omin. Aft	34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t nange stored wi lowing thi ved to stal a series	13 method e plus the f nall not e: 6 hours red g table: e followin Within <u>d</u> Not more There sh th no volta is period t bilized at limiting re	e measur ls, The carated ripp cated ripp covering g require 4.3 shall 25% of a than 20 all be no all be no age applic he capac room ter esistor(11	ed at 120 upacitor is le currente rated w time at at ments. be satisfi initial va 0% of the leakage of ed at a ten itors shall uperature $c\pm 100 \Omega$	Hz. s stored a t for Tab rorking v mospher ed ilue. specifie of electro mperatur l be remo for 4~8) with E	tt a temp ble 1. (T voltage) ic condi ed value. lyte. re of 105 oved fro hours. D.C. rate	erature of he sum of Then the tions. The $\pm 2^{\circ}C$ for m the tes Next they ed voltage
	life test Shelf life	<condition>According to$105^{\circ}C \pm 2$ withDC and rippingproduct shouldresult should<criteria>The characterLeakageCapacetan δAppea<td>IEC6038 ith DC bi le peak v ld be testa meet the ristic sha ge curren itance Ch rance are then burs. Foll be allow nected to Omin. Aft</td><td>34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t nange stored wi lowing thi ved to stal a series</td><td>13 method e plus the f nall not e: 6 hours red g table: e followin Within <u>d</u> Not more There sh th no volta is period t bilized at limiting re</td><td>e measur ls, The carated ripp cated ripp covering g require 4.3 shall 25% of a than 20 all be no all be no age applic he capac room ter esistor(11</td><td>ed at 120 upacitor is le currente rated w time at at ments. be satisfi initial va 0% of the leakage of ed at a ten itors shall uperature $c\pm 100 \Omega$</td><td>Hz. s stored a t for Tab rorking v mospher ed ilue. specifie of electro mperatur l be remo for 4~8) with E</td><td>tt a temp ble 1. (T voltage) ic condi ed value. lyte. re of 105 oved fro hours. D.C. rate</td><td>erature of he sum of Then the tions. The $\pm 2^{\circ}C$ for m the tes Next they ed voltage</td></criteria></condition>	IEC6038 ith DC bi le peak v ld be testa meet the ristic sha ge curren itance Ch rance are then burs. Foll be allow nected to Omin. Aft	34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t nange stored wi lowing thi ved to stal a series	13 method e plus the f nall not e: 6 hours red g table: e followin Within <u>d</u> Not more There sh th no volta is period t bilized at limiting re	e measur ls, The carated ripp cated ripp covering g require 4.3 shall 25% of a than 20 all be no all be no age applic he capac room ter esistor(11	ed at 120 upacitor is le currente rated w time at at ments. be satisfi initial va 0% of the leakage of ed at a ten itors shall uperature $c\pm 100 \Omega$	Hz. s stored a t for Tab rorking v mospher ed ilue. specifie of electro mperatur l be remo for 4~8) with E	tt a temp ble 1. (T voltage) ic condi ed value. lyte. re of 105 oved fro hours. D.C. rate	erature of he sum of Then the tions. The $\pm 2^{\circ}C$ for m the tes Next they ed voltage

		<criteria></criteria>	
		The characteristic shall meet the fo	
	Shelf	0	alue in 4.3 shall be satisfied
4.8	life		ithin ± 25 of initial value.
ч. 0	test		ot more than 200% of the specified value.
			here shall be no leakage of electrolyte.
			d more than 1 year, the leakage current may
			ugh about 1 k Ω resistor, if necessary.
4.9	Surge test	The capacitor shall be submitted to followed discharge of 5 min 30s.The test temperature shall be 15~ C_R :Nominal Capacitance (μ F)Criteria>Leakage currentNo Capacitance ChangeWitten δ No 	acitor connected with a $(100 \pm 50)/C_R (k\Omega)$ resistor. 0.1000 cycles, each consisting of charge of 30 ± 5 s, $35^{\circ}C$. At more than the specified value. At more than the specified v
4.10	Vibration test	perpendicular directions. Vibration frequency range Peak to peak amplitude Sweep rate Mounting method: The capacitor with diameter greater in place with a bracket. 4mm or less 4mm or less To Criteria> After the test, the following items Inner construction No int No da No method	applied for 2 hours in each 3 mutually : 10Hz ~ 55Hz : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute r than 12.5mm or longer than 25mm must be fixed Within 30° Within 30° be soldered shall be tested: ermittent contacts, open or short circuiting. mage of tab terminals or electrodes. echanical damage in terminal. No leakage etrolyte or swelling of the case.

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	1 1						
		<condition></condition>		0.11	11.1		
		The capacitor shall be tes	ted under th		ondition	IS:	
		Soldering temperature		: 245±3°C			
	Caldanah ilitaa	Dipping depth		: 2mm	,		
4.11	Solderability test	Dipping speed		: 25±2.5mm/	S		
	lest	Dipping time <criteria></criteria>		: 3±0.5s			
		<criteria></criteria>		A minimum	of 05%	of the surface	abaing
		Coating quality		immersed	01 7570	of the surface	coung
		<condition></condition>					
		Terminals of the capacitor					
		1 seconds or $400 \pm 10^{\circ}$ C for	$r3^{+1}_{-0}$ second	s to 1.5~2.0n	nm from	the body of	capacitor .
		Then the capacitor shall b					
	Resistance to	for 1~2 hours before mea			1		5
4.12	solder heat	<c<u>riteria></c<u>					
	test	Leakage current	Not	more than th	e specif	ied value.	
		Capacitance Change	Wit	hin $\pm 10\%$ of	f initial	value.	
		tan δ	Not	more than th	e specif	ied value.	
		Appearance	The	re shall be no	leakage	e of electroly	te.
		<condition></condition>	rding to IEC	60284 AND	17matha	da conceitor	- aball ba
		Temperature Cycle:Accor placed in an oven, the cor				ous, capacitor	shall be
		1	emperature	luing us beib		Time	
		(1)+20°C	emperature		≤3	Minutes	
		(1)+20 C (2)Rated low temperative	atura (10°))(25°C)	30 ± 2	Minutes	
	Change of		· ·				
4.13	temperature	(3)Rated high temper		C)	30 ± 2	Minutes	
	test	(1) to $(3)=1$ cycle, to	tal 5 cycle				
		<criteria> The characteristic shall m</criteria>	and the falle	wing roquiro	mont		
		Leakage current		re than the sp		voluo	7
		tan δ		re than the sp			-
				hall be no lea			-
		Appearance	There's		inage OI	electrolyte.	
		<condition></condition>					
		Humidity Test:	ANTA 4 10	41		11	f 500 9
		According to IEC60384-4		· •		-	
		hours in an atmosphere of		H .at 40 ± 2 (\mathcal{L} , the ch	laracteristic c	nange snall
		meet the following requirement. Criteria >					
	Domn haat	Leakage current	Not more	Not more than the specified value.]
4.14	Damp heat test	Capacitance Change		20% of initia			-
	1051	$\tan \delta$		than 120% of		cified value	-
		Appearance		l be no leaka	•		-
		- ppouruneo	1 more bitu		<u> </u>		L
I							

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ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



4.15	Vent test	<condition> The following test only apply to those products with vent products at diameter $\ge \emptyset 6.3$ with vent. D.C. test The capacitor is connected with its polarity reversed to a DC power source. Then a current selected from below table is applied. <table 3=""> $\overrightarrow{Diameter (mm)}$ $\overrightarrow{DC Current (A)}$ 22.4 or less 1 $\overrightarrow{Over 22.4}$ 10 Criteria> The vent shall operate with no dangerous conditions such as flames or dispersion of pieces of the capacitor and/or case.</table></condition>
4.16	Maximum permissible (ripple current)	Condition> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exceed the rated voltage and shall not reverse voltage. Frequency Multipliers: Coefficient Freq. Coefficient (Hz) 50 120 300 1k 100k 39~330 0.60 0.70 0.85 0.95 1.00

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances
	Cadmium and cadmium compounds
Heavy metals	Lead and lead compounds
ficavy filetais	Mercury and mercury compounds
	Hexavalent chromium compounds
	Polychlorinated biphenyls (PCB)
Chloinated	Polychlorinated naphthalenes (PCN)
organic	Polychlorinated terphenyls (PCT)
compounds	Short-chain chlorinated paraffins(SCCP)
	Other chlorinated organic compounds
D · (1	Polybrominated biphenyls (PBB)
Brominated	Polybrominated diphenylethers(PBDE) (including
organic	decabromodiphenyl ether[DecaBDE])
compounds	Other brominated organic compounds
Tributyltin comp	pounds(TBT)
Triphenyltin con	npounds(TPT)
Asbestos	
Specific azo con	npounds
Formaldehyde	
Beryllium oxide	
Beryllium copp	ber
Specific phthalat	tes (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)
Hydrofluorocarb	oon (HFC), Perfluorocarbon (PFC)
Perfluorooctane	sulfonates (PFOS)
Specific Benzoti	riazole

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Attachment: Application Guidelines

1.Circuit Design

- 1.1 Operating Temperature and Frequency
 - Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters
 a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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(6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification. 1.6 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths. 1.7 The Product endurance should take the sample as the standard. 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling. 1.9 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures. CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure. 2.Capacitor Handling Techniques 2.1 Considerations Before Using (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about $1k\Omega$. (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately $1k\Omega$. (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result. 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection. 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve. 2.4 Flow Soldering (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result. (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.

- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
 - : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.
- 2.8 Mounting Adhesives and Coating Agents
 - When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

- 3.1 Environmental Conditions
 - Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures. If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.
- If electrolyte or gas is ingested by month, gargle with water.
 - If electrolyte of gas is ingested by month, gargie with water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000 Ω , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.